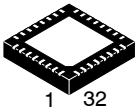
NCP81239, NCP81239A
USB Power Delivery 4-Switch Buck Boost Controller



QFN32 5x5, 0.5P
CASE 485CE

The NCP81239 USB Power Delivery (PD) Controller is a synchronous buck boost that is optimized for converting battery voltage or adaptor voltage into power supply rails required in notebook, tablet, and desktop systems, as well as many other consumer devices using USB PD standard and C−Type cables. The NCP81239 is fully compliant to the USB Power Delivery Specification when used in conjunction with a USB PD or C−Type Interface Controller. NCP81239 is designed for applications requiring dynamically controlled slew rate limited output voltage that require either voltage higher or lower than the input voltage. The NCP81239 drives 4 NMOSFET switches, allowing it to buck or boost and support the functions specified in the USB Power Delivery Specification which is suitable for all USB PD applications. The USB PD Buck Boost Controller operates with a supply and load range of 4.5 V to 32 V. NCP81239A is functionally same as NCP81239 except with different I^2C address.

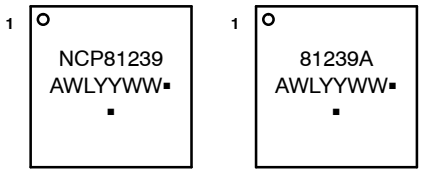
Features

- Wide Input Voltage Range: from 4.5 V to 32 V
- Dynamically Programmed Frequency from 150 kHz to 1.2 MHz
- I^2C Interface
- Real Time Power Good Indication
- Controlled Slew Rate Voltage Transitioning
- Feedback Pin with Internally Programmed Reference
- Support USBPD/QC2.0/QC3.0 Profile
- 2 Independent Current Sensing Inputs
- Over Temperature Protection
- Adaptive Non−Overlap Gate Drivers
- Filter Capacitor Switch Control
- Over−Voltage and Over−Current Protection
- Dead Battery Power Support
- 5 x 5 mm QFN32 Package

Typical Applications

- Notebooks, Tablets, Desktops
- All in Ones
- Monitors, TV s, and Set Top Boxes
- Consumer Electronics
- Car Chargers
- Docking Stations
- Power Banks

MARKING DIAGRAM



A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
▪ = Pb−Free Package
(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping†
NCP81239MNTXG	QFN32 (Pb−Free)	2500 / Tape & Reel
NCP81239AMNTXG	QFN32 (Pb−Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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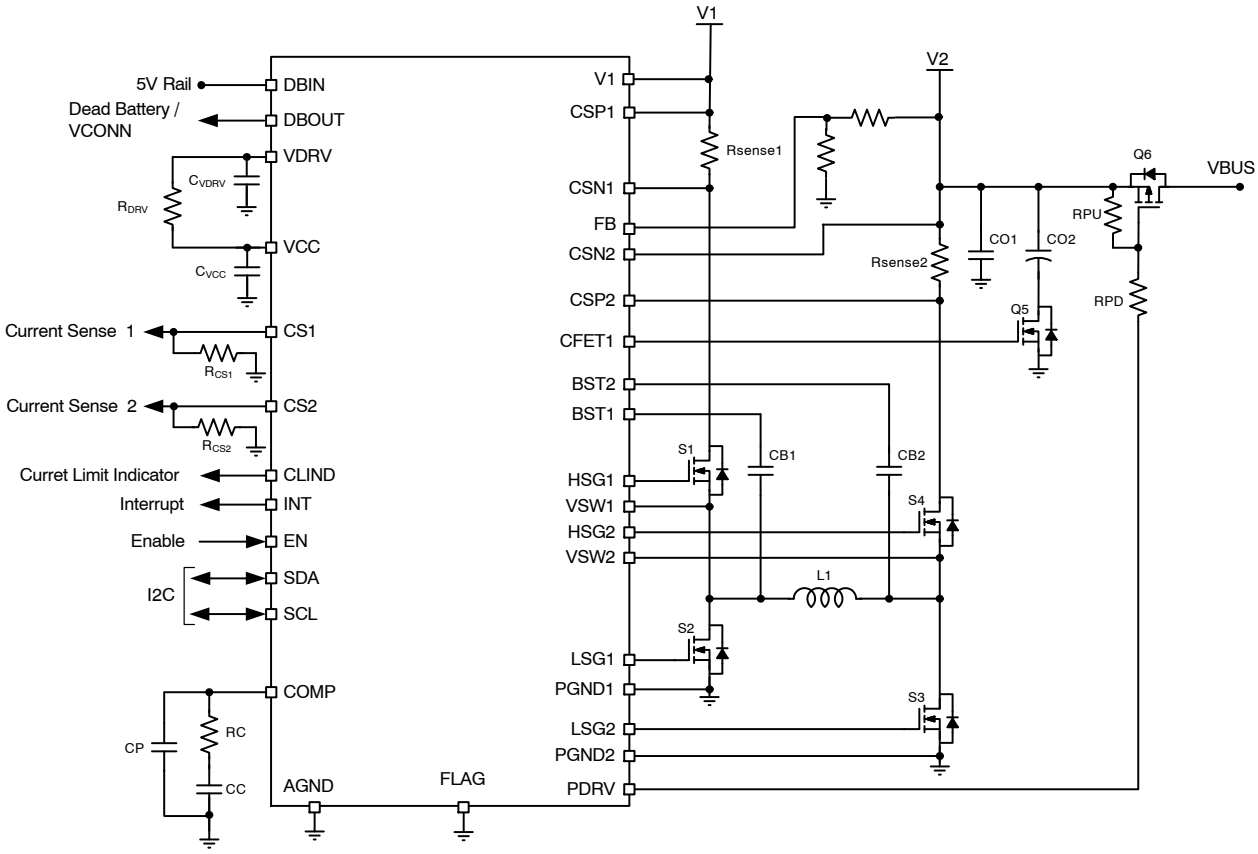

Figure 1. Typical Application Circuit

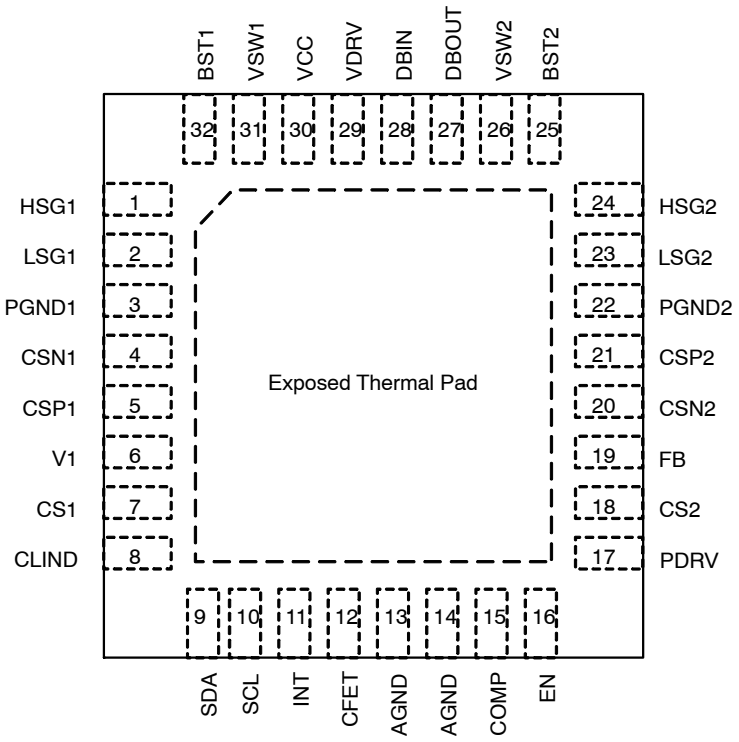

Figure 2. Pinout

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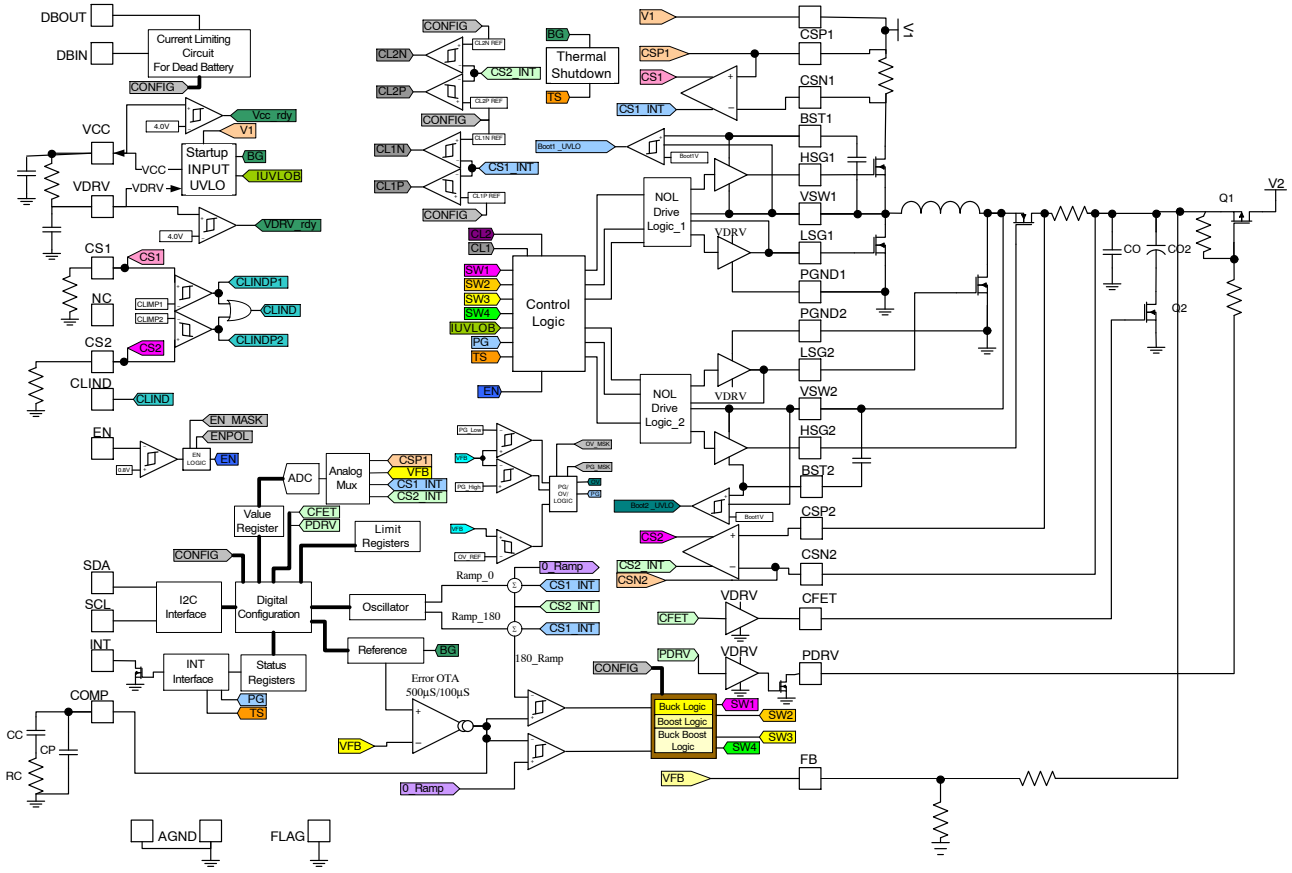

Figure 3. Block Diagram

Table 1. PIN FUNCTION DESCRIPTION

Pin	Pin Name	Description
1	HSG1	S1 gate drive. Drives the S1 N−channel MOSFET with a voltage equal to VDRV superimposed on the switch node voltage VSW1.
2	LSG1	Drives the gate of the S2 N−channel MOSFET between ground and VDRV.
3, 22	PGND	Power ground for the low side MOSFET drivers. Connect these pins closely to the source of the bottom N−channel MOSFETs.
4	CSN1	Negative terminal of the current sense amplifier.
5	CSP1	Positive terminal of the current sense amplifier.
6	V1	Input voltage of the converter
7	CS1	Current sense amplifier output. CS1 will source a current that is proportional to the voltage across RS1 to an external resistor. CS1 voltage can be monitored with a high impedance input. Ground this pin if not used.
8	CLIND	Open drain output to indicate that the CS1 or CS2 voltage has exceeded the I^2C programmed limit.
9	SDA	I^2C interface data line.
10	SCL	I^2C interface clock line.
11	INT	Interrupt is an open drain output that indicates the state of the output power, the internal thermal trip, and other I^2C programmable functions.
12	CFET	Controlled drive of an external MOSFET that connects a bulk output capacitor to the output of the power converter. Necessary to adhere to low capacitance limits of the standard USB Specifications for power prior to USB PD negotiation.
13−14	AGND	The ground pin for the analog circuitry.
15	COMP	Output of the transconductance amplifier used for stability in closed loop operation.

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Table 1. PIN FUNCTION DESCRIPTION

Pin	Pin Name	Description
16	EN	Precision enable starts the part and places it into default configuration when toggled.
17	PDRV	The open drain output used to control a PMOSFET.
18	CS2	Current sense amplifier output. CS2 will source a current that is proportional to the voltage across RS2 to an external resistor. CS2 voltage can be monitored with a high impedance input. Ground this pin if not used.
19	FB	Feedback voltage of the output, negative terminal of the gm amplifier.
20	CSN2	Negative terminal of the current sense amplifier.
21	CSP2	Positive terminal of the current sense amplifier.
23	LSG2	Drives the gate of the S3 N−channel MOSFET between ground and VDRV.
24	HSG2	S4 gate drive. Drives the S4 N−channel MOSFET with a voltage equal to VDRV superimposed on the switch node voltage VSW2.
25	BST2	Bootstrapped Driver Supply. The BST2 pin swings from a diode voltage below VDRV up to a diode voltage below VOUT + VDRV. Place a 0.1 μF capacitor from this pin to VSW2.
26	VSW2	Switch Node. VSW2 pin swings from a diode voltage drop below ground up to output voltage.
27	DBOUT	The output of the dead battery circuit which can also be used for the VCONN voltage supply.
28	DBIN	The dead battery input to the converter where 5 V is applied. A 1 μF capacitor should be placed close to the part to decouple this line.
29	VDRV	Internal voltage supply to the driver circuits. A 1 μF capacitor should be placed close to the part to decouple this line.
30	VCC	The VCC pin supplies power to the internal circuitry. The VCC is the output of a linear regulator which is powered from V1. Pin should be decoupled with a 1 μF capacitor for stable operation.
31	VSW1	Switch Node. VSW1 pin swings from a diode voltage drop below ground up to V1.
32	BST1	Driver Supply. The BST1 pin swings from a diode voltage below VDRV up to a diode voltage below V1 + VDRV. Place a 0.1 μF capacitor from this pin to VSW1.
33	THPAD	Center Thermal Pad. Connect to AGND externally.

Table 2. MAXIMUM RATINGS Over operating free−air temperature range unless otherwise noted

Rating	Symbol	Min	Max	Unit
Input of the Dead Battery Circuit	DBIN	−0.3	5.5	V
Output of the Dead Battery Circuit	DBOUT	−0.3	5.5	V
Driver Input Voltage	VDRV	−0.3	5.5	V
Internal Regulator Output	VCC	−0.3	5.5	V
Output of Current Sense Amplifiers	CS1, CS2	−0.3	3.0	V
Current Limit Indicator	CLIND	−0.3	VCC + 0.3	V
Interrupt Indicator	INT	−0.3	VCC + 0.3	V
Enable Input	EN	−0.3	5.5	V
I^2C Communication Lines	SDA, SCL	−0.3	VCC + 0.3	V
Compensation Output	COMP	−0.3	VCC + 0.3	V
V1 Power Stage Input Voltage	V1	−0.3	32 V, 40 V (20 ns)	V
Positive Current Sense	CSP1	−0.3	32 V, 40 V (20 ns)	V
Negative Current Sense	CSN1	−0.3	32 V, 40 V (20 ns)	V
Positive Current Sense	CSP2	−0.3	32 V, 40 V (20 ns)	V
Negative Current Sense	CSN2	−0.3	32 V, 40 V (20 ns)	V
Feedback Voltage	FB	−0.3	5.5	V
CFET Driver	CFET	−0.3	VCC + 0.3	V

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Table 2. MAXIMUM RATINGS Over operating free−air temperature range unless otherwise noted

Rating	Symbol	Min	Max	Unit
Driver 1 and Driver 2 Positive Rails	BST1, BST2	−0.3 V wrt/PGND −0.3 V wrt/VSW	37 V, 40 V (20 ns) wrt/PGND 5.5 V wrt/VSW	V
High Side Driver 1 and Driver 2	HSG1, HSG2	−0.3 V wrt/PGND −0.3 V wrt/VSW	37 V, 40 V (20 ns) wrt/GND 5.5 V wrt/VSW	V
Switching Nodes and Return Path of Driver 1 and Driver 2	VSW1, VSW2	−5.0 V	32 V, 40 V (20 ns)	V
Low Side Driver 1 and Driver 2	LSG1, LSG2	−0.3 V	5.5	V
PMOSFET Driver	PDRV	−0.3	32 V, 40 V (20 ns)	V
Voltage Differential	AGND to PGND	−0.3	0.3	V
CSP1−CSN1, CSP2−CSN2 Differential Voltage	CS1DIF, CS2DIF	−0.5	0.5	V
PDRV Maximum Current	PDRVI	0	10	mA
PDRV Maximum Pulse Current (100 ms on time, with > 1 s interval)	PDRVIPUL	0	200	mA
Maximum VCC Current	VCCI	0	80	mA
Operating Junction Temperature Range (Note 1)	TJ	−40	150	°C
Operating Ambient Temperature Range	TA	−40	100	°C
Storage Temperature Range	TSTG	−55	150	°C
Thermal Characteristics (Note 2) QFN 32 5mm x 5mm Maximum Power Dissipation @ TA = 25°C Maximum Power Dissipation @ TA = 85°C Thermal Resistance Junction−to−Air with Solder Thermal Resistance Junction−to−Case Top with Solder Thermal Resistance Junction−to−Case Bottom with Solder	 PD PD RΘJA RΘJCT RΘJCB	 4.1 2.1 30 1.7 2.0		 W W °C/W °C/W °C/W
Lead Temperature Soldering (10 sec): Reflow (SMD styles only) Pb−Free (Note 3)	RF	260 Peak		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The maximum package power dissipation limit must not be exceeded.
2. The value of ΘJA is measured with the device mounted on a 3in x 3in, 4 layer, 0.062 inch FR−4 board with 1.5 oz. copper on the top and bottom layers and 0.5 ounce copper on the inner layers, in a still air environment with T_A = 25°C.
3. 60−180 seconds minimum above 237°C.

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Table 3. RECOMMENDED OPERATION RATINGS

Rating	Symbol	Value		Units
		Min	Max	
Driver Input Voltage	VDRV	4.5	5.5	V
Internal Regulator Output	VCC	4.5	5.5	V
Current Limit Indicator	CLIND	−0.3	VCC+0.3	V
Interrupt Indicator	INT	−0.3	VCC+0.3	V
Enable Input	EN	−0.3	5.5	V
I2C Communication Lines	SDA, SCL	−0.3	VCC+0.3	V
Compensation Output	COMP	−0.3	VCC+0.3	V
Power Stage Input Voltage to PGND	V1	4.5	28	V
Input Side Current Sense Pins	CSP1, CSN1	−0.3	28	V
Output Side Current Sense Pins	CSP2, CSN2	−0.3	28	V
Driver Positive Rails to PGND	BST1, BST2	−0.3	33	V
High Side Driver 1 and 2	HSG1, HSG2	−0.3	33	V
Switching Nodes and Return Path of Driver 1 and 2 to PGND	VSW1, VSW2	−2	28	V
Low Side Driver 1 and 2	LSG1, LSG2	−0.3	5.5	V
FB Voltage	FB	−0.3	5.5	V
Voltage Differential	AGND to PGND	−0.3	0.3	V
CSP1−CSN1, CSP2−CSN2 Differential Voltage	CS1DF, CS2DF	−0.5	0.5	V
Operating Junction Temperature Range	TJ	−40	150	°C
Operating Ambient Temperature Range	TA	−40	100	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 4. ELECTRICAL CHARACTERISTICS

(V1 = 12 V, V_{out} = 1.0 V , T_A = +25°C for typical value; −40°C < T_A < 100°C for min/max values unless noted otherwise)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
POWER SUPPLY						
V1 Operating Input Voltage	V1		4.5		32	V
VDRV Operating Input Voltage	VDRV		4.5	5	5.5	V
VCC UVLO Rising Threshold	VCC_{START}			4.3		V
UVLO Hysteresis for VCC	$VCCV_{HYS}$	Falling Hysteresis		300		mV
VDRV UVLO Rising Threshold	$VDRV_{START}$			4.3		V
UVLO Hysteresis for VDRV	$VDRV_{HYS}$	Falling Hysteresis		300		mV
VCC Output Voltage	VCC	With no external load	4.5	5		V
VCC Drop Out Voltage	VCCDROOP	30 mA load		150		mV
VCC Output Current Limit	$IOUT_{VCC}$	VCC Loaded to 4.3 V	80	97		mA
V1 Shutdown Supply Current	IVCC_SD	EN = 0 V, 4.3 V ≤ V1 ≤ 28 V		6.6	7.7	mA
VDRIVE Switching Current Buck	IV1_SW	EN = 5 V, Cgate = 2.2 nF, VSW = 0 V, FSW = 600 kHz		15		mA
VDRIVE Switching Current Boost	IV1_SW	EN = 5 V, Cgate = 2.2 nF, VSW = 0 V, FSW = 600 kHz		15		mA

4. Ensured by design. Not production tested.

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(V1 = 12 V, V_{out} = 1.0 V , T_A = +25°C for typical value; −40°C < T_A < 100°C for min/max values unless noted otherwise)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
VOLTAGE OUTPUT						
Voltage Output Accuracy	FB	DAC_TARGET = 00110010 DAC_TARGET = 01111000 DAC_TARGET = 11001000	0.495 1.188 1.98	0.5 1.2 2.0	0.505 1.212 2.02	V
Voltage Accuracy Over Temperature	VFB_T	VFB ≥ 0.5 V VFB < 0.5 V	−1.0 −5		1.0 5	% mV
	VFB_R	T_A = 25°C VFB ≥ 0.5 V	 −0.45		 0.45	%
TRANSCONDUCTANCE AMPLIFIER						
Gain Bandwidth Product	GBW	(Note 4)		5.2		MHz
Transconductance	GM1	Default		500		μS
Max Output Source Current limit	GMSOC		60	80		μA
Max Output Sink Current limit	GMSIC		60	80		μA
Voltage Ramp	Vramp			1.4		V
INTERNAL BST DIODE						
Forward Voltage Drop	VFBOT	I_F = 10 mA, T_A = 25°C	0.35	0.46	0.55	V
Reverse Bias Leakage Current	DIL	BST−VSW = 5 V V_{SW} = 28 V, T_A = 25°C		0.05	1	μA
BST−VSW UVLO	$BST1_{UVLO}$	Rising, Note 4		3.5		V
BST−VSW Hysteresis	BST_{HYS}	Note 4		300		mV
OSCILLATOR						
Oscillator Frequency	FSW_0	FSW = 000, default	528	600	672	kHz
	FSW_1	FSW = 001	132	150	168	kHz
	FSW_7	FSW = 110	1056	1200	1344	kHz
Oscillator Frequency Accuracy	FSWE		−12		12	%
Minimum On Time	MOT	Measured at 10% to 90% of VCC		50		ns
Minimum Off Time	MOFT	Measured at 90% to 10% of VCC		90		ns
INT THRESHOLDS						
Interrupt Low Voltage	VINTI	IINT(sink) = 2 mA			0.2	V
Interrupt High Leakage Current	INII	3.3 V		3	100	nA
Interrupt Startup Delay	INTPG	Soft Start end to PG positive edge		2.1		ms
Interrupt Propagation Delay	PGI	Delay for power good in		3.3		ms
	PGO	Delay for power good out		100		ns
Power Good Threshold	PGTH	Power Good in from high		105		%
	PGTH	Power Good in from low		95		%
	PGTHYS	PG falling hysteresis		2.5		%
FB Overvoltage Threshold	FB_OV			120		%
Overvoltage Propagation Delay	VFB_OVDL			1 Cycle		
EXTERNAL CURRENT SENSE (CS1,CS2)						
Positive Current Measurement High	CS10	CSP1−CSN1 or CSP2−CSN2 = 100 mV		500		μA

4. Ensured by design. Not production tested.

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(V1 = 12 V, V_{out} = 1.0 V , T_A = +25°C for typical value; −40°C < T_A < 100°C for min/max values unless noted otherwise)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
EXTERNAL CURRENT SENSE (CS1,CS2)						
Transconductance Gain Factor	CSGT	Current Sense Transconductance Vsense = 1 mV to 100 mV		5		mS
Transconductance Deviation	CSGE		−20		20	%
Current Sense Common Mode Range	CSCMMR		3		32	V
−3 dB Small Signal Bandwidth	CSBW	VSENSE (AC) = 10 mVPP, RGAIN = 10 kΩ (Note 4)		30		MHz
Input Sense Voltage Full Scale	ISVFS				100	mV
CS Output Voltage Range	CSOR	VSENSE = 100 mV Rset = 6k	0		3	V
EXTERNAL CURRENT LIMIT (CLIND)						
Current Limit Indicator Output Low	CLINDL	Input current = 500 μA		5.6	100	mV
Current Limit Indicator Output High Leakage Current	ICLINDH	Pull up to 5 V		500		μA
INTERNAL CURRENT SENSE						
Internal Current Sense Gain for PWM	ICG	CSPx−CSNx = 100 mV	9.2	9.8	10.5	V/V
Positive Peak Current Limit Trip	PPCLT	INT_CL = 00	34	39	44	mV
Negative Valley Current Limit Trip	NVCLT	INT_CL_NEG = 00	31	40	45	mV
SWITCHING MOSFET DRIVERS						
HSG1 HSG2 Pullup Resistance	HSG_PU	BST−VSW = 4.5 V		2.8		Ω
HSG1 HSG2 Pulldown Resistance	HSG_PD	BST−VSW = 4.5 V		1.2		Ω
LSG1 LSG2 Pullup Resistance	LSG_PU	LSG −PGND = 2.5 V		3.3		Ω
LSG1 LSG2 Pulldown Resistance	LSG_PD	LSG −PGND = 2.5 V		0.9		Ω
HSG Falling to LSG Rising Delay	HSLSD			15		ns
LSG Falling to HSG Rising Delay	LSHSD			15		ns
CFET						
CFET Drive Voltage	CFETDV			VCC		V
Source/Sink Current	CFETSS	CFET clamped to 2 V		2		μA
Pull Down Delay	CFETD	Measured at 10% to 90% of VCC		10		ms
CFET Pull Down Resistance	CFETR	Measured with 1 mA Pull up Current, after 10ms rising edge delay		1.3		kΩ
SLEW RATE/SOFT START						
Charge Slew Rate	SLEWP	Slew = 00, FB = 0.1 VOUT Slew = 11, FB = 0.1 VOUT		0.6 4.8		mV/μs
Discharge Slew Rate	SLEWN	Slew = 00, FB = 0.1 VOUT Slew = 11, FB = 0.1 VOUT		−0.6 −4.8		mV/μs
Prebias Level	PBLV	FB=0.1VOUT		300		mV
DEAD BATTERY/VCONN						
Dead Battery Input Voltage Range	VDB		4.5	5	5.25	V
Dead Battery Output Voltage	VIO	VDB = 5 V, Output Current 32 mA	4	4.7	5	V
Dead Battery Current Limit	DB_LIM	VDB = 5 V, DBOUT greater than 2 V	29	57		mA

4. Ensured by design. Not production tested.

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Table 4. ELECTRICAL CHARACTERISTICS
(V1 = 12 V, V_{out} = 1.0 V , T_A = +25°C for typical value; −40°C < T_A < 100°C for min/max values unless noted otherwise)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
ENABLE						
EN High Threshold Voltage	ENHT	EN_MASK = ENPU = ENPOL = 0		798	820	mV
EN Low Threshold Voltage	ENLT		640	665		mV
EN Pull Up Current	IEN_UP	EN = 0 V		5		μA
EN Pull Down Current	IEN_DN	EN = VCC		5		μA
I²C INTERFACE						
Voltage Threshold	I2CVTH		0.95	1	1.05	V
Propagation Delay	I2CPD	(Note 4)		25		ns
Communication Speed	I2CSP				1	MHz
THERMAL SHUTDOWN						
Thermal Shutdown Threshold	TSD	(Note 4)		151		°C
Thermal Shutdown Hysteresis	TSDHYS	(Note 4)		28		°C
PDRV						
PDRV Operating Range			0		28	V
PDRV Leakage Current	PDRV_IDS	FET OFF, VPDRV = 28 V		180		nA
PDRV Saturation Voltage	PDRV_VDS	ISNK = 10 mA		0.20		V
INTERNAL ADC						
Range	ADCRN	(Note 4)	0		2.55	V
LSB Value	ADCLSB	(Note 4)		20		mV
Error	ADCFE	(Note 4)		1		LSB

4. Ensured by design. Not production tested.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

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APPLICATION INFORMATION

Dual Edge Current Mode Control

When dual edge current mode control is used, two voltage ramps are generated that are 180 degrees out of phase. The inductor current signal is added to the ramps to incorporate current mode control. In Figure 4, the COMP signal from the compensation output interacts with two triangle ramps to generate gate signals to the switches from S1 to S4. Two ramp signals cross twice at midpoint within a cycle. When COMP is above the midpoint, the system will operate at boost mode with S1 always on and S2 always off, but S3 and S4 turning on alternatively in an active switching mode. When COMP is below the midpoint, the system will operation at buck mode, with S4 always on and S3 always off, but S1 and S2 turning on alternatively in an active switching mode. The controller can switch between buck and boost mode smoothly based on the COMP signal from peak current regulation.

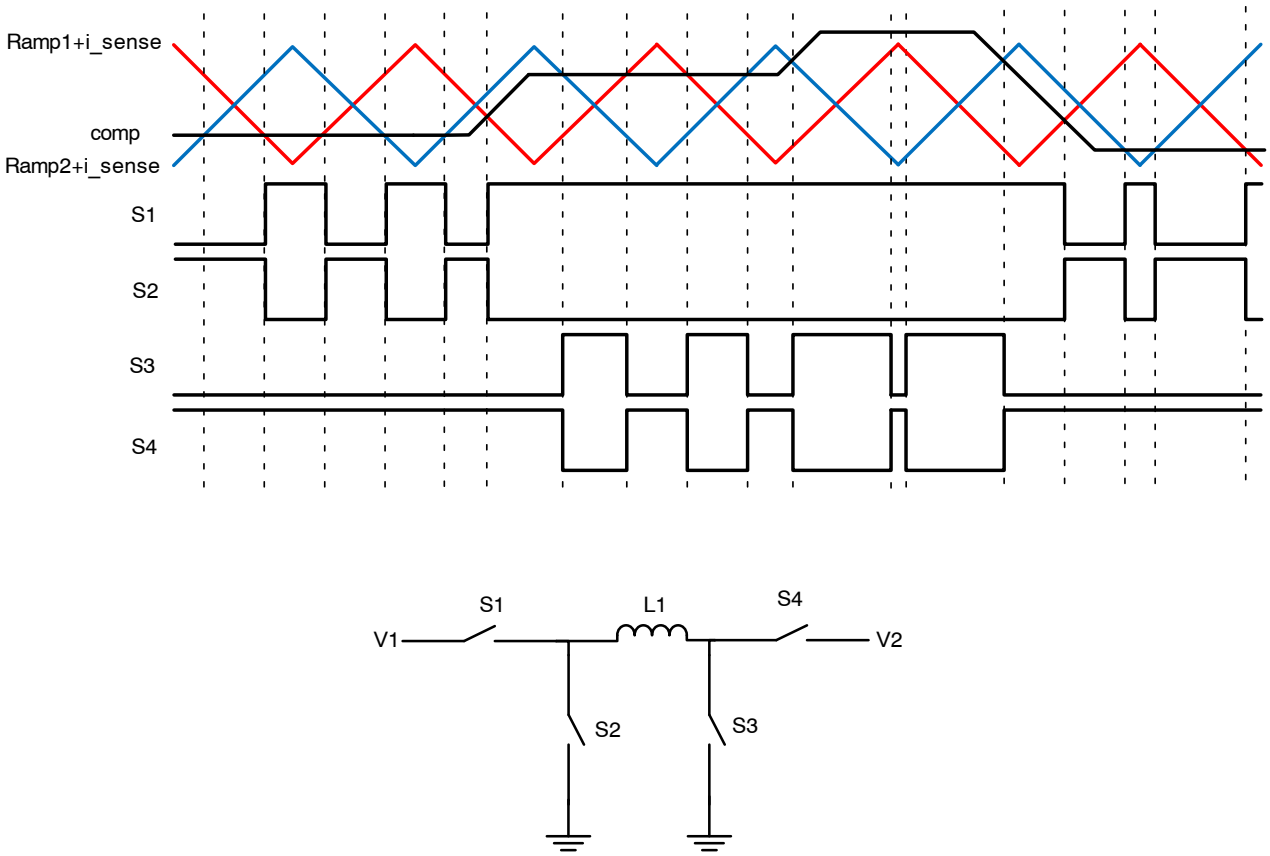

Figure 4. Transitions for Dual Edge 4 Switch Buck Boost

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Feedback and Output Voltage Profile

The feedback of the converter output voltage is connected to the FB pin of the device through a resistor divider. Internally FB is connected to the inverting input of the internal transconductance error amplifier. The non−inverting input of the gm amplifier is connected to the internal reference. The internal reference voltage is by default 0.5 V. Therefore a 10:1 resistor divider from the converter output to the FB will set the output voltage to 5 V in default. The reference voltage can be adjusted with 10 mV(default) or 5 mV steps from 0.1 V to 2.55 V through the voltage profile register (01H), which makes the continuous output voltage profile possible through an external resistor divider. For example, by default, if the external resistor divider has a 10:1 ratio, the output voltage profile will be able to vary from 1 V to 25.5 V with 100 mV steps.

It is recommended to avoid using output voltage profile below 0.1 V. When 0 V output is needed, one can disable NCP81239 by pulling EN pin low with external circuit or use software to write EN registers (00h) through I2C. Setting output voltage profile to 0 via I2C is not recommended.

Table 5. VOLTAGE PROFILE REGISTER SETTINGS

dac_target (01h)								Voltage Profile Hex Value	dac_target_lsb (03h, bit 4)	Reference Voltage (mV)
bit_8	bit_7	bit_6	bit_5	bit_4	bit_3	bit_2	bit_1			
0	0	0	0	0	0	0	0	00H	0	Reserved
…	…	…	…	…	…	…	…	…	…	…
0	0	0	0	1	0	0	1	09H	1	Reserved
0	0	0	0	1	0	1	0	0AH	0	100
0	0	0	0	1	0	1	0	0AH	1	105
…	…	…	…	…	…	…	…	…	…	…
0	0	1	1	0	0	1	0	32H	0	500(Default)
…	…	…	…	…	…	…	…	…	…	…
1	1	0	0	1	0	0	0	C8H	0	2000
…	…	…	…	…	…	…	…	…	…	…
1	1	1	1	1	1	1	1	FFH	0	2550
1	1	1	1	1	1	1	1	FFH	1	2555

Transconductance Voltage Error Amplifier

To maintain loop stability under a large change in capacitance, the NCP81239 can change the gm of the internal transconductance error amplifier from 87 μS to 1000 μS allowing the DC gain of the system to be increased more than a decade triggered by the adding and removal of the bulk capacitance or in response to another user input. The default transconductance is 500 μS.

Table 6. AVAILABLE TRANSCONDUCTANCE SETTING

AMP_2	AMP_1	AMP_0	Amplifier GM Value (μS)
0	0	0	87
0	0	1	100
0	1	0	117
0	1	1	333
1	0	0	400
1	0	1	500
1	1	0	667
1	1	1	1000

Programmable Slew Rate

The slew rate of the NCP81239 is controlled via the I^2C registers with the default slew rate set to 0.6 mV/μs (FB = 0.1 V2, assume the resistor divider ratio is 10:1) which is the slowest allowable rate change. The slew rate is used when the output voltage starts from 0 V to a user selected profile level, changing from one profile to another, or when the output voltage is dynamically changed. The output voltage is divided by a factor of the external resistor divider and connected to FB pin. The 9 Bit DAC is used to

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increase the reference voltage in 10 or 5 mV increments. The slew rate is decreased by using a slower clock that results in a longer time between voltage steps, and conversely increases by using a faster clock. The step monotonicity depends on the bandwidth of the converter where a low bandwidth will result in a slower slew rate than the selected value. The available slew rates are shown in Table 6. The selected slew rate is maintained unless the current limit is tripped; in which case the increased voltage will be governed by the positive current limit until the output voltage falls or the fault is cleared.

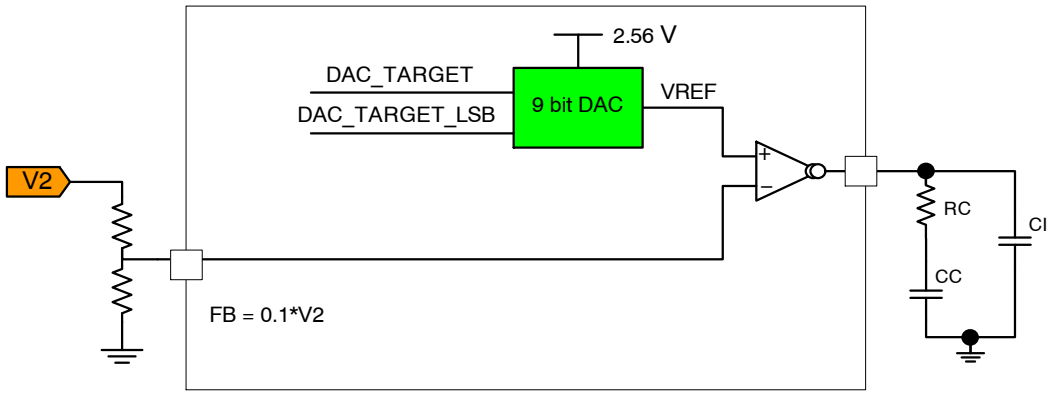

Figure 5. Slew Rate Limiting Block Diagram and Waveforms

Table 7. SLEW RATE SELECTION

Slew Bits	Soft Start or Voltage Transition (FB = 0.1*V2)
Slew_0	0.6 mV/μs
Slew_1	1.2 mV/μs
Slew_2	2.4 mV/μs
Slew_3	4.8 mV/μs

The discharge slew rate is accomplished in much the same way as the charging except the reference voltage is decreased rather than increased. The slew rate is maintained unless the negative current limit is reached. If the negative current limit is reached, the output voltage is decreased at the maximum rate allowed by the current limit (see the negative current limit section).

Soft Start

During a 0 V soft start, standard converters can start in synchronous mode and have a monotonic rising of output voltage. If a prebias exists on the output and the converter starts in synchronous mode, the prebias voltage could be discharged. The NCP81239 controller ensures that if a prebias (lower than the input) is detected, the soft start is completed in a non−synchronous mode to prevent the output from discharging. During softstart, the output rising slew rate will follow the slew rate register with default value set to 0.6 mV/μs (FB = 0.1*V2).

It takes at least 3.3 ms for the digital core to reset all the registers, so it is recommended not to restart a soft start until at least 3.3 ms after the output voltage ramp down to steady state.

Frequency Programming

The switching frequency of the NCP81239 can be programmed from 150 kHz to 1.2 MHz via the I^2C interface. The default switching frequency is set to 600 kHz. The switching frequency can be changed on the fly. However, it is a good practice to disable the part and then program to a different frequency to avoid transition glitches at large load current.

Table 8. FREQUENCY PROGRAMMING TABLE

Name	Bit	Definition	Description
Freq1	03H [2:0]	Frequency Setting	3 Bits that Control the Switching Frequency from 150 kHz to 1 MHz. 000: 600 kHz 001: 150 kHz 010: 300 kHz 011: 450 kHz 100: 750 kHz 101: 900 kHz 110: 1.2 MHz 111: Reserved

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Current Sense Amplifiers

Internal precision differential amplifiers measure the potential between the terminal CSP1 and CSN1 or CSP2 and CSN2. Current flows from the input V1 to the output in a buck boost design. Current flowing from V1 through the switches to the inductor passes through R_{SENSE}. The external sense resistor, R_{SENSE}, has a significant effect on the function of current sensing and limiting systems and must be chosen with care. First, the power dissipation in the resistor should be considered. The system load current will cause both heat and voltage loss in R_{SENSE}. The power loss and voltage drop drive the designer to make the sense resistor as small as possible while still providing the input dynamic range required by the measurement. Note that input dynamic range is the difference between the maximum input signal and the minimum accurately measured signal, and is limited primarily by input DC offset of the internal amplifier. In addition, R_{SENSE} must be small enough that V_{SENSE} does not exceed the maximum input voltage 100 mV, even under peak load conditions.

The potential difference between CSPx and CSNx is level shifted from the high voltage domain to the low voltage VCC domain where the signal is split into two paths.

The first path, or external path, allows the end user to observe the analog or digital output of the high side current sense. The external path gain is set by the end user allowing the designer to control the observable voltage level. The voltage at CS1 or CS2 can be converted to 7 bits by the ADC and stored in the internal registers which are accessed through the I^2C interface.

The second path, or internal path, has internally set gain of 10 and allows cycle by cycle precise limiting of positive and negative peak input current limits.

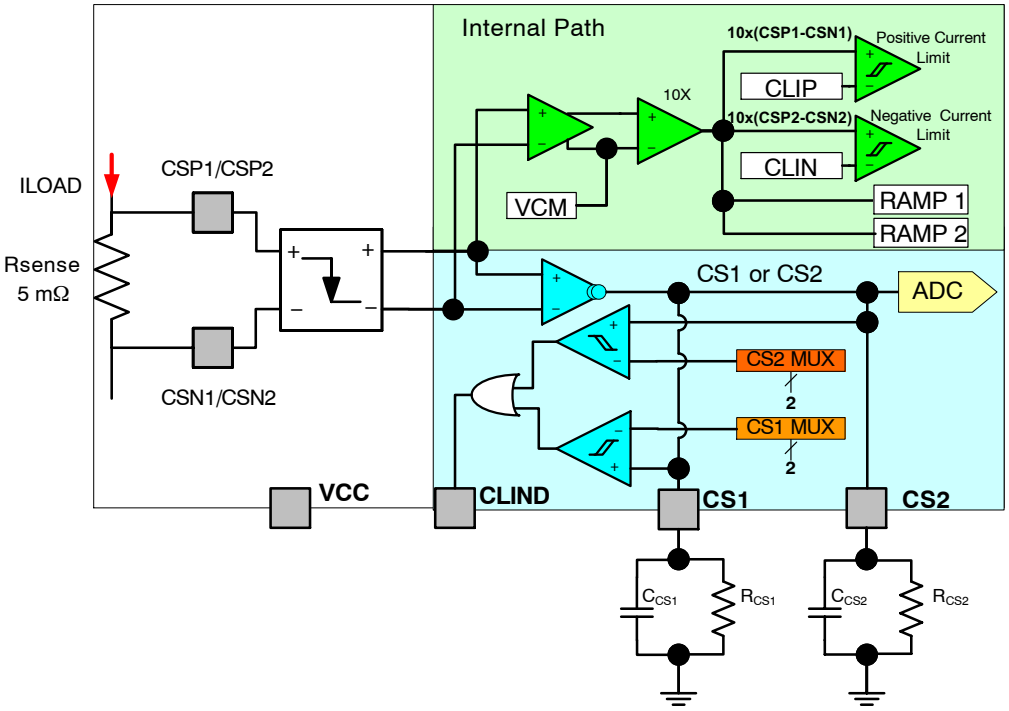

Figure 6. Block Diagram and Typical Connection for Current Sense

Positive Current Limit Internal Path

The NCP81239 has a pulse by pulse current limiting function activated when a positive current limit triggers. CSP1/CSN1 will be the positive current limit sense channel.

When a positive current limit is triggered, the current pulse is truncated. In both buck mode and in boost mode the S1 switch is turned off to limit the energy during an over current event. The current limit is reset every switching cycle and waits for the next positive current limit trigger. In this way, current is limited on a pulse by pulse basis. Pulse by pulse current limiting is advantageous for limiting energy into a load in over current situations but are not up to the task of limiting energy into a low impedance short. To address the low impedance short, the NCP81239 does pulse by pulse current limiting for 2 ms known as Ilim timeout, the controller will enter into fast stop. The NCP81239 remains in fast stop state with all switches driven off for 10 ms. Once the 10 ms has expired, the part is allowed to soft start to the previously programmed voltage and current level if the short circuit condition is cleared.

The internal current limits can be controlled via the I^2C interface as shown in Table 9.

After extended time of OCP, the controller may shutdown and go to latched up mode. Resetting the input voltage (V1) will clear this fault.

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Table 9. INTERNAL PEAK CURRENT LIMIT

CLIN_1	CLIN_0	CSP2−CSN2 (mV)	Current at RSENSE = 5 mΩ (A)
0	0	−40 (Default)	−8
0	1	−25	−5
1	0	−15	−3
1	1	0	0
CLIP_1	**CLIP_0**	**CSP1−CSN1 (mV)**	**Current at RSENSE = 5 mΩ (A)**
0	0	38 (Default)	7.6
0	1	23	4.6
1	0	11	2.2
1	1	70	14

Negative Current Limit Internal Path

Negative current limit can be activated in a few instances, including light load synchronous operation, heavy load to light load transition, output overvoltage, and high output voltage to lower output voltage transitions. CSP2/CSN2 will be the negative current limit sense channel.

During light load synchronous operation, or heavy load to light load transitions the negative current limit can be triggered during normal operation. When the sensed current exceeds the negative current limit, the S4 switch is shut off preventing the discharge of the output voltage both in buck mode and in boost mode if the output is in the power good range. Both in boost mode and in buck mode when a negative current is sensed, the S4 switch is turned off for the remainder of either the S4 or S2 switching cycle and is turned on again at the appropriate time. In buck mode, S4 is turned off at the negative current limit transition and turned on again as soon as the S2 on switch cycle ends. In boost mode, the S4 switch is the rectifying switch and upon negative current limit the switch will shut off for the remainder of its switching cycle. The internal negative current limits can be controlled via the I^2C interface as shown in Table 9.

External Path (CS1, CS2, CLIND)

The voltage drop across the sense resistors as a result of the load can be observed on the CS1 and CS2 pins. Both CS1, CS2 can be monitored with a high impedance input. The voltage drop is converted into a current by a transconductance amplifier with a typical GM of 5 mS. The final gain of the output is determined by the end users selection of the R_{CS} resistors. The output voltage of the CS pin can be calculated from Equation 1. The user must be careful to keep the dynamic range below 2.56 V when considering the maximum short circuit current.

$$V_{CS} = \left(I_{AVERAGE} * R_{SENSE} * Trans\right) * R_{CS} < 2.56V \quad \text{(eq. 1)}$$

$$\Rightarrow R_{CS} = \frac{V_{CS}}{I_{AVERAGE} * R_{SENSE} * Trans} < \frac{2.56\ V}{I_{MAX} * R_{SENSE} * Trans}$$

The speed and accuracy of the dual amplifier stage allows the reconstruction of the input and output current signal, creating the ability to limit the peak current. If the user would like to limit the mean DC current of the switch, a capacitor can be placed in parallel with the R_{CS} resistors. CS1, CS2 can be monitored with a high impedance input. An external series resistor can be added for additional filtering.

CS1, CS2 voltages are connected internally to 2 high speed low offset comparators. The comparators output can be used to suspend operation until reset or restart of the part depending on I^2C configuration. When the external CLIND flag is triggered, it indicates that one of the internal comparators has exceeded the preset limit (CSx_LIM). The default comparator setting is 250 mV which is a limit of 500 mA with a current sense resistor of 5 mΩ and an R_{CS} resistor of 20 kΩ.

CLIND may misbehave when EN toggles. It is because the internal analog circuit is not fully functional when EN is just asserted. One solution is to force the CLIND low during EN is low and release CLIND after certain time after EN goes high.

Table 10. REGISTER SETTING FOR THE CLIM COMPARATORS

CLIMx_1	CLIMx_0	CSx_LIM (V)	Current at R_{SENSE} = 5 mΩ R_{CSx} = 20 kΩ (A)	Current at R_{SENSE} = 5 mΩ R_{CSx} = 10 kΩ (A)
0	0	0.25	.5	1
0	1	0.75	1.5	3
1	0	1.5	3	6
1	1	2.5	5	10

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Overvoltage Protection (OVP)

When the divided output voltage is 120% (typical) above the internal reference voltage for greater than one switching cycle, an OV fault is set. During an overvoltage fault, S1 is driven off, S2 is driven on, and S3 and S4 are modulated to discharge the output while preventing the inductor current from going beyond the I^2C programmed negative current limit.

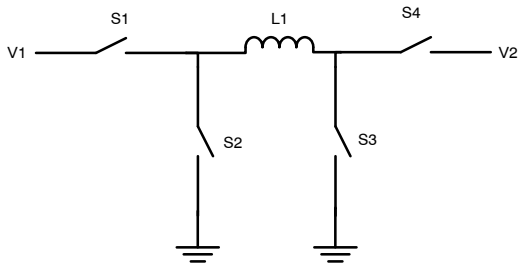

Figure 7. Diagram for OV Protection

During overvoltage fault detection the switching frequency changes from its I^2C set value to 50 kHz to reduce the power dissipation in the switches and prevent the inductor from saturating. OVP is disabled during voltage changes to ensure voltage changes and glitches during slewing are not falsely reported as faults. The OV faults are reengaged 1 ms after completion of the soft start.

When the output voltage profile is set below 100 mV, it is easy to trigger OVP falsely. So it is better for one to avoid using output voltage profile under 100 mV. When 0 V output voltage is needed, one can pull EN pin low with external circuit or write to EN registers (00h) through I^2C to disable NCP81239. Setting output voltage profile to 0 via I^2C is not recommended.

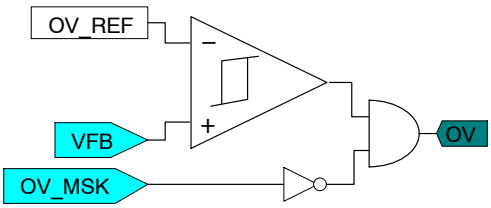

Figure 8. OV Block Diagram

Table 11. OVERVOLTAGE MASKING

OV_MSK	Description
0	OV Action and Indication Unmasked
1	OV Action and Indication Masked

Power Good Monitor (PG)

NCP81239 provides two window comparators to monitor the internal feedback voltage. The target voltage window is ±5% of the reference voltage (typical). Once the feedback voltage is within the power good window, a power good indication is asserted once a 3.3 ms timer has expired. If the feedback voltage falls outside a ±7.5% window for greater than 1 switching cycle, the power good register is reset. Power good is indicated on the INT pin if the I^2C register is set to display the PG state. During startup, INT is set until the feedback voltage is within the specified range for 3.3 ms.

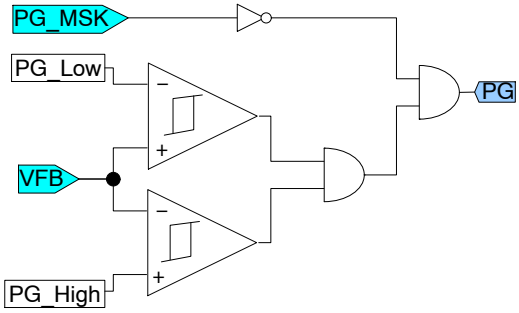

Figure 9. PG Block Diagram

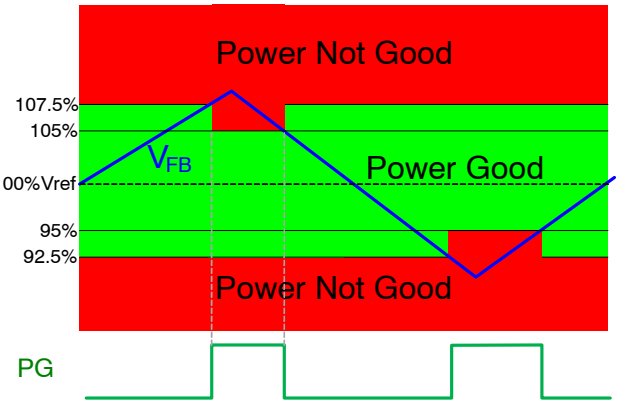

Figure 10. PG Diagram

Table 12. POWER GOOD MASKING

PG_MSK	Description
0	PG Action and Indication Unmasked
1	PG Action and Indication Masked

Thermal Shutdown

The NCP81239 protects itself from overheating with an internal thermal shutdown circuit. If the junction temperature exceeds the thermal shutdown threshold (typically 150°C), all MOSFETs will be driven to the off state, and the part will wait until the temperature decreases to an acceptable level. The fault will be reported to the fault register and the INT flag will be set unless it is masked. When the junction temperature drops below 125°C (typical), the part will discharge the output voltage to Vsafe 0 V.

CFET Turn On

The CFET is used to engage the output bulk capacitance after successful negotiations between a consumer and a provider. The USB Power Delivery Specification requires that no more than 30 μF of capacitance be present on the VBUS rail when sinking power. Once the consumer and

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provider have completed a power role swap, a larger capacitance can be added to the output rail to accommodate a higher power level. The bulk capacitance must be added in such a way as to minimize current draw and reduce the voltage perturbation of the bus voltage. The NCP81239 incorporates a right drive circuit that regulates current into the gate of the MOSFET such that the MOSFET turns on slowly reducing the drain to source resistance gradually. Once the transition from high to low has occurred in a controlled way, a strong pulldown driver is used to ensure normal operation does not turn on the power N−MOSFET engaging the bulk capacitance. The CFET must be activated through the I^2C interface where it can be engaged and disengaged. The default state is to have the CFET disengaged.

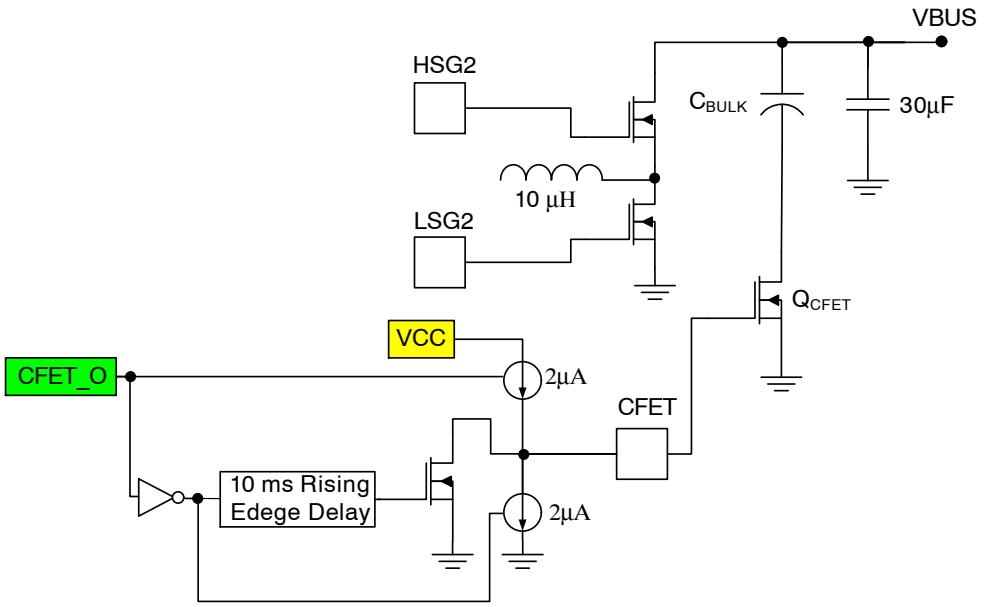

Figure 11. CFET Drive

Table 13. CFET ACTIVATION TABLE

CFET_0	Description
0	CFET Pin Pulldown
1	CFET Pin Pull Up

PFET Drive

The PMOS drive is an open drain output used to control the turn on and turn off of PMOSFET switches at a floating potential. The external PMOS can be used as a cutoff switch, enable for an auxiliary power supply, or a bypass switch for a power supply. The RDSon of the pulldown NMOSFET is typically 20 Ω allowing the user to quickly turn on large PMOSFET power channels.

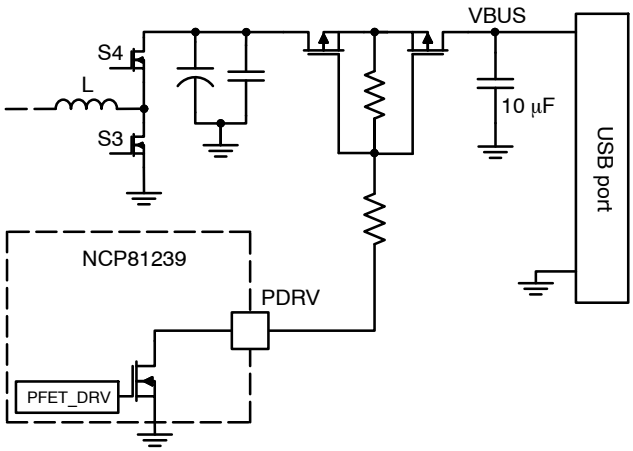

Figure 12. PFET Drive

Table 14. PFET ACTIVATION TABLE

PFET_DRV	Description
0	NFET OFF (Default)
1	NFET ON

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Analog to Digital Converter

The analog to digital converter is a 7−bit A/D which can be used as an event recorder, an input voltage sampler, output voltage sampler, input current sampler, or output current sampler. The converter digitizes real time data during the sample period. The internal precision reference is used to provide the full range voltage; in the case of V1(input voltage), or FB (with 10:1 external resistor divider) the full range is 0 V to 25.5 V. The V1 is internally divided down by 10 before it is digitized by the ADC, thus the range of the measurement is 0 V−2.55 V, same as FB. The resolution of the V1 and FB voltage is 20 mV at the analog mux, but since the voltage is divided by 10 output voltage resolution will be 200 mV. When CS1 and CS2 are sampled, the range is 0 V−2.55 V. The resolution will be 20 mV in the CS monitoring case. The actual current can be calculated by dividing the CS1 or CS2 values with the factor of Rsense × 5mS × $R_{CS1/2}$, the total gain from the current input to the external current monitoring outputs.

The ADC trigger register is called amux_trigger in the register map. It is recommended to set this register before enabling the controller. If a change on the fly is necessary, it is recommended to reset to 0 first before setting to a new value.

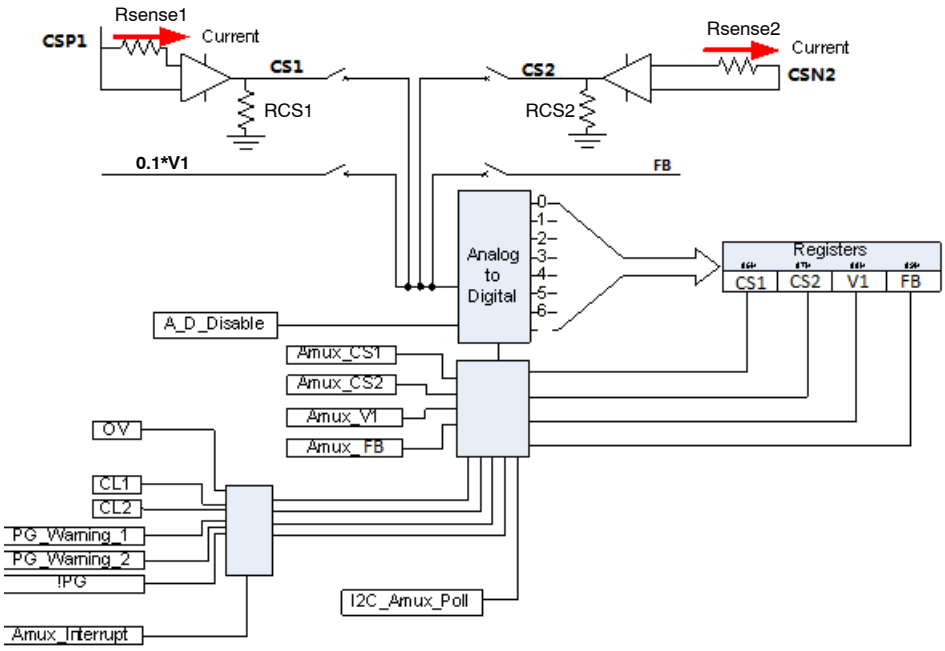

Figure 13. Analog to Digital Converter

Table 15. ADC BYTE

	MSB	5	4	3	2	1	LSB
DATA	D6	D5	D4	D3	D2	D1	D0

Table 16. REGISTER SETTING FOR ENABLING DESIRED ADC BEHAVIOR

ADC_1	ADC_0	Description
0	0	Set Amux to VFB
0	1	Sets Amux to V1
1	0	Set Amux to CS2
1	1	Set Amux to CS1

Table 17. REGISTER SETTING FOR ADC TRIGGER MANNER

ADC Trigger	Description
00	Trigger a 1xread by a fault condition (Default)
01	Trigger a 1xread
10	Trigger a continuous read

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Interrupt Control

The interrupt controller continuously monitors internal interrupt sources, generating an interrupt signal when a system status change is detected. Individual bits generating interrupts will be set to 1 in the INTACK register (I^2C read only registers), indicating the interrupt source. All interrupt sources can be masked by writing 1 in register INTMSK. Masked sources will never generate an interrupt request on the INT pin. The INT pin is an open drain output. A non−masked interrupt request will result in the INT pin being driven high. Figure 14 illustrates the interrupt process.

The interrupt source registers (14h,15h) always read 0 when any interrupt happens. The solution is to first keep Int_mask_XXX registers (09h) low by default. INT can toggle after any fault happens. Then set int_mask_XXX registers to high, it will flag the corresponding interrupt source registers if the fault is still there. Now the interrupt source registers can be read. In the end, set int_mask_XXX registers to low again after reading interrupt status registers.

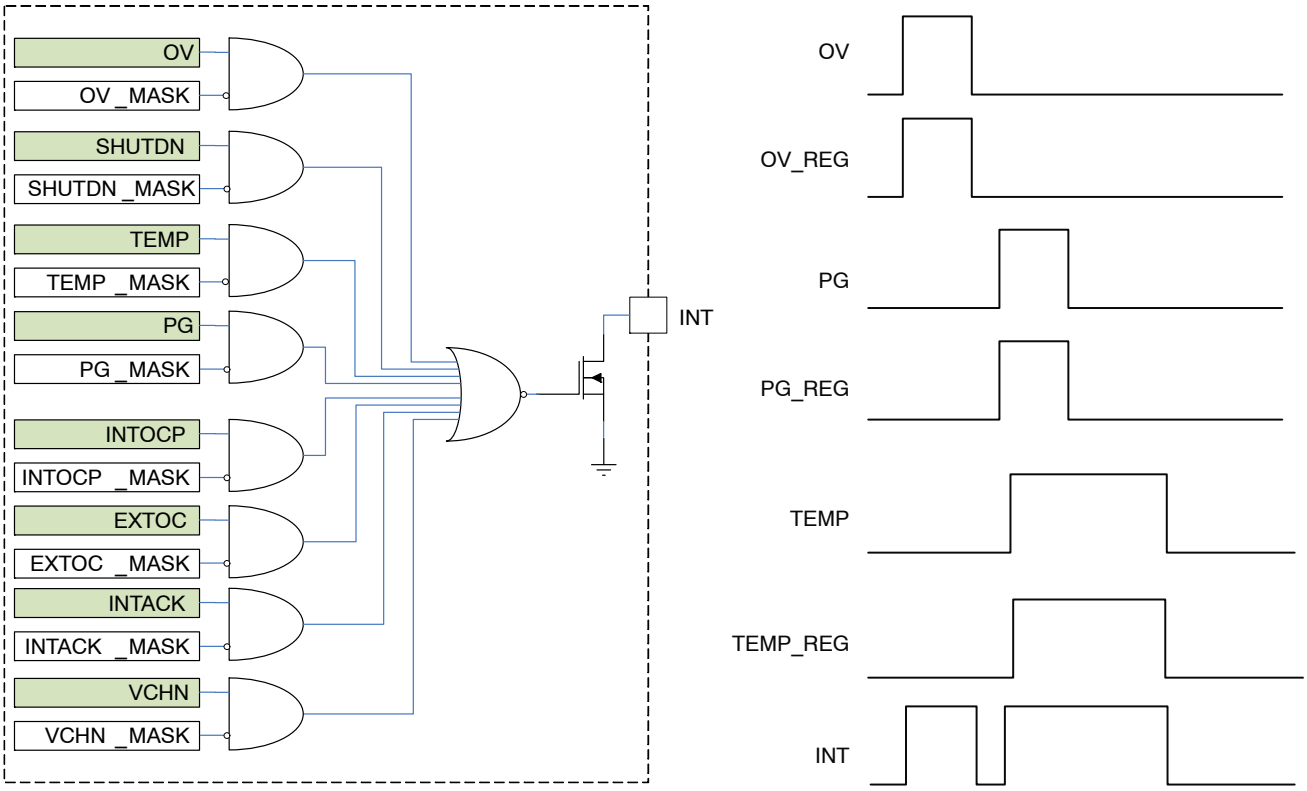

Figure 14. Interrupt Logic

Table 18. INTERPRETATION TABLE

Interrupt Name	Description
OV	Output Over Voltage
Shutdown	Shutdown Detection (EN=low)
TEMP	IC Thermal Trip
PG	Power Good Trip Thresholds Exceeded
INTOCP	Internal Current Limit Trip
EXTOC	External Current Trip from CLIND
VCHN	Output Negative Voltage Change
INTACK	I2C ACK signal to the host

I^2C Address

NCP81239 and NCP81239A are functionally same but have different factory I^2C addresses. NCP81239 address is set to 74h, NCP81239A is set to 75h.

Table 19. I^2C ADDRESS

I^2C Address	Hex	A6	A5	A4	A3	A2	A1	A0
NCP81239	0x74	1	1	1	0	1	0	0
NCP81239A	0x75	1	1	1	0	1	0	1

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I²C Interface

The I²C interface can support 5 V TTL, LVTTL, 2.5 V and 1.8 V interfaces with two precision SCL and SDA comparators with 1 V thresholds shown in Figure 15. The part cannot support 5 V CMOS levels as there can be some ambiguity in voltage levels.

I²C Compatible Interface

The NCP81239 can support a subset of I²C protocol as detailed below. The NCP81239 communicates with the external processor by means of a serial link using a 400 kHz up to 1.2 MHz I²C two−wire interface protocol. The I²C interface provided is fully compatible with the Standard, Fast, and High−Speed I²C modes. The NCP81239 is not intended to operate as a master controller; it is under the control of the main controller (master device), which controls the clock (pin SCL) and the read or write operations through SDA. The I²C bus is an addressable interface (7−bit addressing only) featuring two Read/Write addresses.

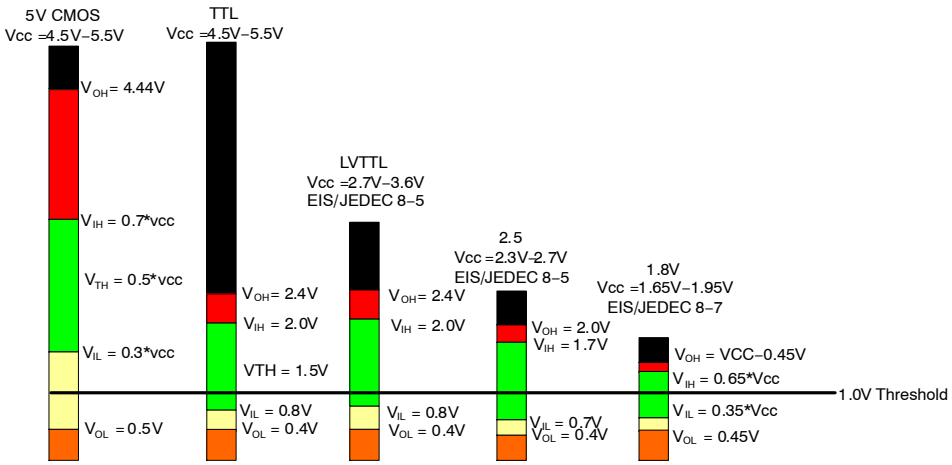

Figure 15. I²C Thresholds and Comparator Thresholds

I2C Communication Description

The first byte transmitted is the chip address (with the LSB bit set to 1 for a Read operation, or set to 0 for a Write operation). Following the 1 or 0, the data will be:

- In case of a Write operation, the register address (@REG) pointing to the register for which it will be written is followed by the data that will written in that location. The writing process is auto−incremental, so the first data will be written in @REG, the contents of @REG are incremented, and the next data byte is placed in the location pointed to @REG + 1..., etc.
- In case of a Read operation, the NCP81239 will output the data from the last register that has been accessed by the last write operation. Like the writing process, the reading process is auto−incremental.

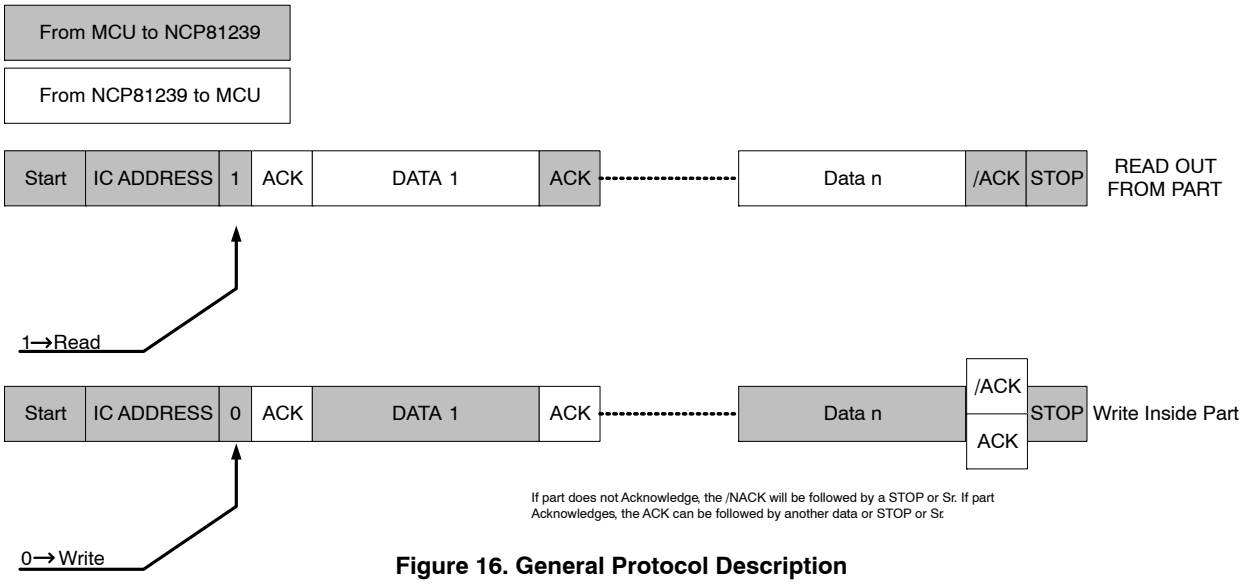

Figure 16. General Protocol Description

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Read Out from Part

The master will first make a “Pseudo Write” transaction with no data to set the internal address register. Then, a stop then start or a repeated start will initiate the Read transaction from the register address the initial Write transaction was pointed to:

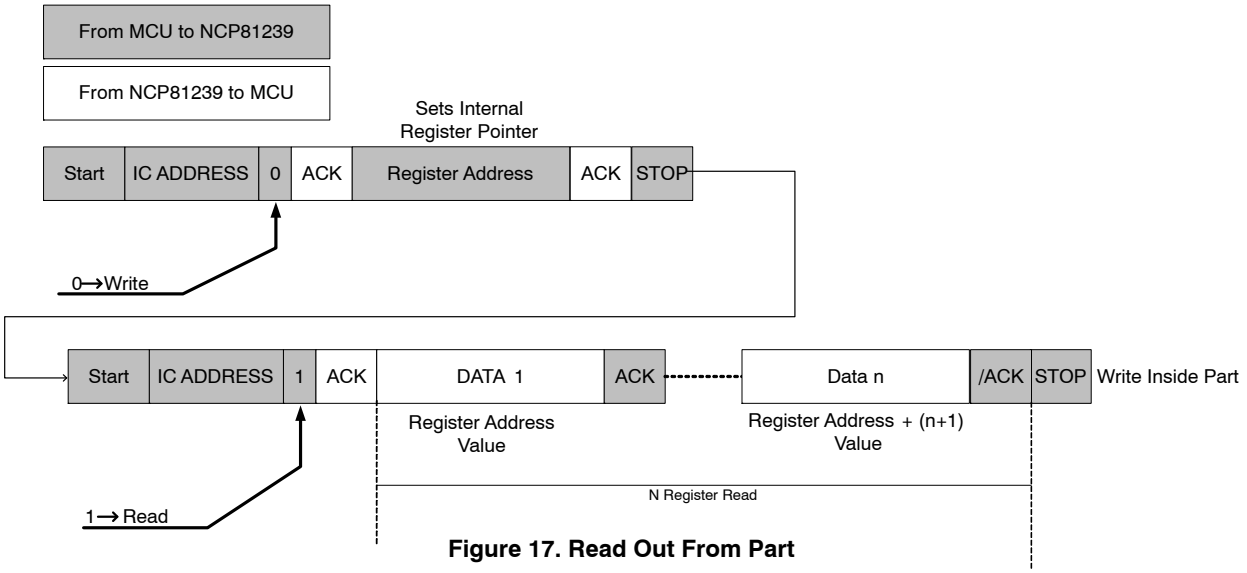

Figure 17. Read Out From Part

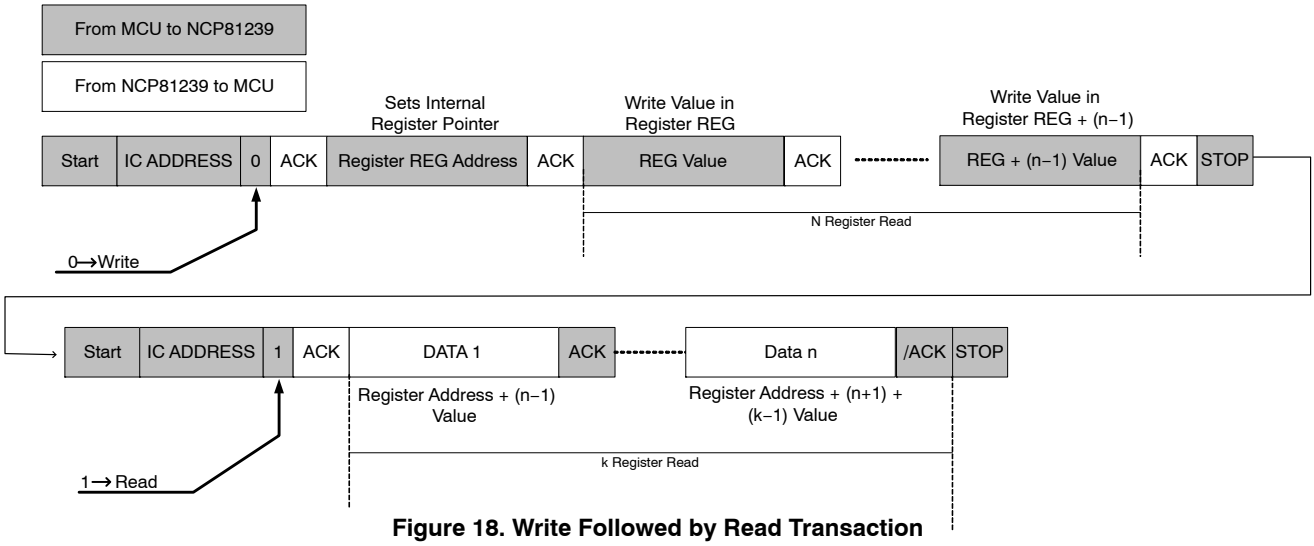

Figure 18. Write Followed by Read Transaction

Write In Part

Write operation will be achieved by only one transaction. After the chip address, the MCU first data will be the internal register desired to access, the following data will be the data written in REG, REG + 1, REG + 2, ..., REG + (n−1).

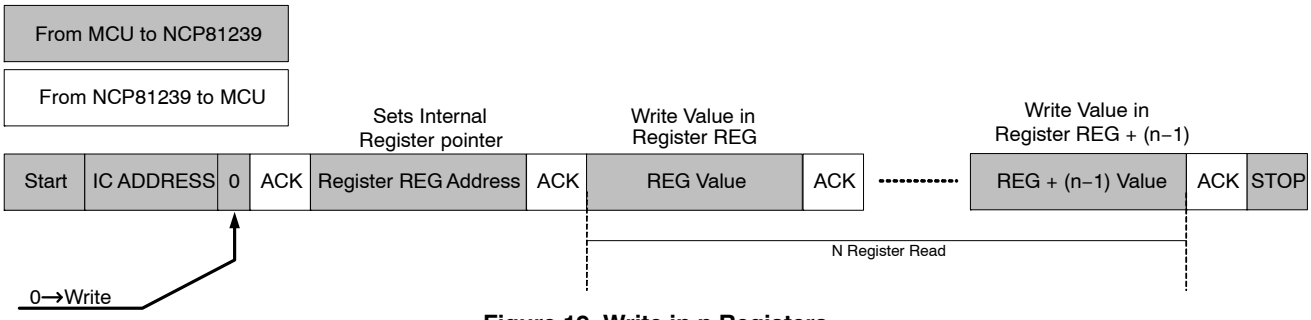

Figure 19. Write in n Registers

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I²C Communication Considerations

- It takes at least 3.3 ms for the digital core to reset all the registers, so it is recommended not to change the register value until at least 3.3 ms after the output voltage finish ramping to a steady state.
- It is recommended to avoid setting reference voltage profile below 0.1 V. When 0 V output is needed, it is recommended to ramp down the output by pulling EN pin low with external circuit or by I2C communication in the firmware. Setting output voltage profile to 0 via I2C is not recommended.
- CLIND may misbehave when VCC is setting up and when EN toggles. It is because the internal analog circuit is not fully functional when VCC or EN is just asserted, and CLIND is not intentionally pulled low before the controller's internal analog circuit get fully functional or fully shutdown. External circuit can be added to force the CLIND low when EN is low and release CLIND after certain time after EN goes high. The PD controller can also be used to ignore the CLIND when EN is low or just asserted and only monitor CLIND when EN is high.

Table 20. I2C REGISTER MAP BIT DETAIL

	ADDR (Hex)	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
User-programmable Registers	00h	-	-	-	-	en_int	en_mask	en_pup	en_pol
	01h	dac_target							
	02h	-	-	-	-	-	-	slew_rate	
	03h	-	-	-	dac_target_lsb	-	pwm_frequency		
	04h	-	-	cs2_dchrg	cs1_dchrg	-	dead_battery_en	cfet	pfet
	05h	-	-	ocp_clim_neg		-	-	ocp_clim_pos	
	06h	-				cs2_clind		cs1_clind	
	07h	gm_amp_config	hi_gm_amp_setting			gm_manual	lo_gm_amp_setting		
	08h	-	-	dis_adc	amux_sel			amux_trigger	
	09h	int_mask_i2c_ack	int_mask_vchn	-	int_mask_tsd	int_mask_pg	int_mask_ocp_p	int_mask_ov	int_mask_clind
	0Ah	-	-	-	-	-	-	-	int_mask_shutdown
-	0B .. 0Fh								
User read-only registers	10h	-	vfb						
	11h	-	vin						
	12h	-	cs2						
	13h	-	cs1						
	14h	i2c_ack	vchn	-	tsd	pg_int	ocp_p	ov	ext_clind_ocp
	15h	-	-	-	-	-	-	-	shut_down

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DESIGN CONSIDERATIONS

dv/dt Induced False Turn On

In synchronous buck converters, there is a well−known phenomenon called “low side false turn−on,” or “dv/dt induced turn on”, which can be potentially dangerous for the switch itself and the reliability of the entire converter. The 4−switch buck−boost converter is not exempt from this issue. To make things worse, errors are made when designers simply copy the circuit parameters of a buck converter directly to the boost phase of the 4−switch buck−boost converter.

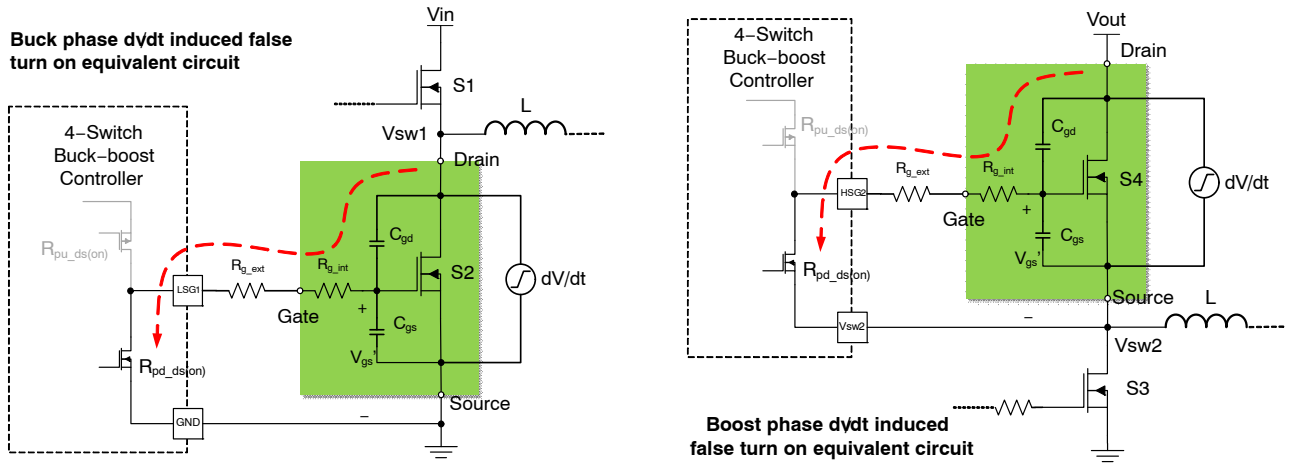

Figure 20. dv/dt Induced False Turn−on Equivalent Circuit of a 4−switch Buck−boost Converter

Figure 20 shows false turn on equivalent circuit of the buck phase and the boost phase at the moment a positive dv/dt transition appears across the drain−to−source junction. The detailed analysis of this phenomenon can be found in Gate Driver Design Considerations for 4−Switch Buck−Boost Converters.

Select the Switching Power MOSFET

The MOSFETs used in the power stage of the converter should have a maximum drain−to−source voltage rating that exceeds the sum of steady state maximum drain−to−source voltage and the turn−off voltage spike with a considerable margin (20%~50%).

When selecting the switching power MOSFET, the MOSFET gate capacitance should be considered carefully to avoid overloading the 5 V LDO. For one MOSFET, the allowed maximum total gate charge Q_g can be estimated by Equation 2:

$$Q_g = \frac{I_{driver}}{f_{sw}} \qquad \text{(eq. 2)}$$

where I_{driver} is the gate drive current and f_{sw} is the switching frequency.

It is recommended to select the MOSFETs with smaller than 3 nF input capacitance (C_{iss}). The gate threshold voltage should be higher than 1.0 V due to the internal adaptive non−overlap gate driver circuit.

In order to prevent dv/dt induced turn−on, the criteria for selecting a rectifying switch is based on the $Q_{gd}/Q_{gs(th)}$ ratio. $Q_{gs(th)}$ is the gate−to−source charge before the gate voltage reaches the threshold voltage. Lowering C_{gd} will reduce dv/dt induced voltage magnitude. Moreover, it also depends on dt/C_{gs}, V_{ds} and threshold voltage V_{th}. One way of interpreting the dv/dt induced turn−on problem is when V_{ds} reaches the input voltage, the Miller charge should be smaller than the total charge on C_{gs} at the V_{th} level, so that the rectifying switches will not be turned on. Then we will have the following relation:

$$V_{gs} = \frac{C_{gd}}{C_{gd} + C_{gs}} \times V_{ds} < V_{gs(th)} \qquad \text{(eq. 3)}$$

$$Q_{gd} < Q_{GS(th)} \qquad \text{(eq. 4)}$$

We can simply use Equation 4 to evaluate the rectifying device’s immunity to dv/dt induced turn on. Ideally, the charge Q_{gd} should not be greater than $1.5*Q_{gs(th)}$ in order to leave enough margin.

Select Gate Drive Resistors

To increase the converter’s dv/dt immunity, the dv/dt control is one approach which is usually related to the gate driver circuit. A first intuitive method is to use higher pull up resistance and gate resistance for the active switch. This would slow down the turn on of the active switch, effectively decreasing the dv/dt. Table 21 shows the recommended value for MOSFETs’ gate resistors.

Table 21. RECOMMENDED VALUE for Gate Resistors

Buck Phase		Boost Phase	
HSG1	(3.3~5.1)Ω	HSG2	0Ω
LSG1	0Ω	LSG2	(3.3~5.1)Ω

An alternative approach is to add an RC snubber circuit to the switching nodes V_{sw1} and V_{sw2}. This is the most direct

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way to reduce the dv/dt. The side effect of the above two methods are that losses would be increased because of slow switching speed.

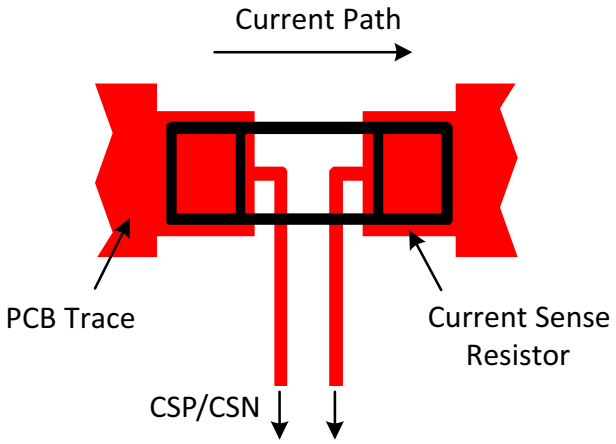
LAYOUT GUIDELINES

Electrical Layout Considerations

Good electrical layout is a key to make sure proper operation, high efficiency, and noise reduction.

- **Current Sensing:** Run two dedicated trace with decent width in parallel (close to each other to minimize the loop area) from the two terminals of the input side or output side current sensing resistor to the IC. Place the common−mode RC filter components in general proximity of the controller.

Route the traces into the pads from the inside of the current sensing resistor. The drawing below shows how to rout the traces.



- **Gate Driver:** Run the high side gate, low side gate and switching node traces in a parallel fashion with decent width. Avoid any sensitive analog signal trace from crossing over or getting close. Recommend routing Vsw1/2 trace to high−side MOSFET source pin instead of copper pour area. The controller should be placed close to the switching MOSFETs gate terminals and keep the gate drive signal traces short for a clean MOSFET drive. It's OK to place the controller on the opposite side of the MOSFETs.
- **I2C Communication:** SDA and SCL pins are digital pins. Run SDA and SCL traces in parallel and reduce the loop area. Avoid any sensitive analog signal trace or noise source from crossing over or getting close.
- **V1 Pin:** Input for the internal LDO. Place a decoupling capacitor in general proximity of the controller. Run a dedicated trace from system input bus to the pin and do not route near the switching traces.
- **VCC Decoupling:** Place decoupling caps as close as possible to the controller VCC pin. Place the RC filter connecting with VDRV pin in general proximity of the controller. The filter resistor should be not higher than 10 Ω to prevent large voltage drop.
- **VDRV Decoupling:** Place decoupling caps as close as possible to the controller VDRV pin.
- **Input Decoupling:** The device should be well decoupled by input capacitors and input loop area should be as small as possible to reduce parasitic inductance, input voltage spike, and noise emission. Usually, a small low−ESL MLCC is placed very close to the input port. Place these capacitors on the same PCB layer with the MOSFETs instead of on different layers and using vias to make the connection.
- **Output Decoupling:** The output capacitors should be as close as possible to the load.
- **Switching Node:** The converter's switching node should be a copper pour to carry the current, but compact because it is also a noise source of electrical and magnetic field radiation. Place the inductor and the switching MOSFETs on the same layer of the PCB.
- **Bootstrap:** The bootstrap cap and an option resistor need to be in general close to the controller and directly connected between pin BST1/2 and pin SW1/2 respectively.
- **Ground:** It would be good to have separated ground planes for PGND and AGND and connect the AGND planes to PGND through a dedicated net tie or 0 Ω resistor.
- **Voltage Sense:** Route a "quiet" path for the input and output voltage sense. AGND could be used as a remote ground sense when differential sense is preferred.
- **Compensation Network:** The compensation network should be close to the controller. Keep FB trace short to minimize it capacitance to ground.

Thermal Layout Considerations

Good thermal layout helps power dissipation and junction temperature reduction.

- The exposed pads must be well soldered on the board.
- A four or more layers PCB board with solid ground planes is preferred for better heat dissipation.
- More free vias are welcome to be around IC and underneath the exposed pads to connect the inner ground layers to reduce thermal impedance.
- Use large area copper pour to help thermal conduction and radiation.
- Do not put the inductor too close to the IC, thus the heat sources are distributed.

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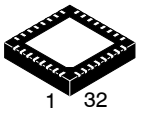
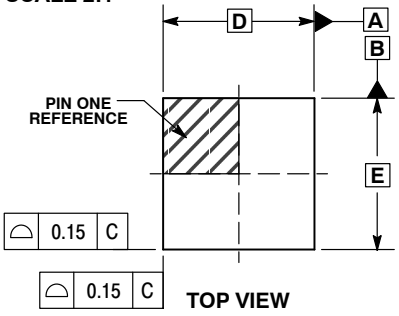
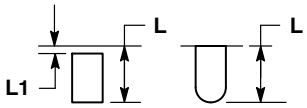
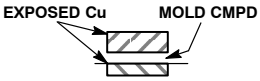


SCALE 2:1

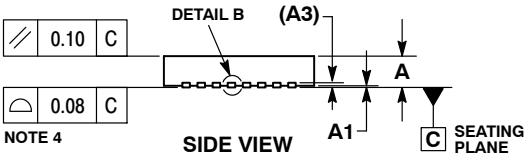


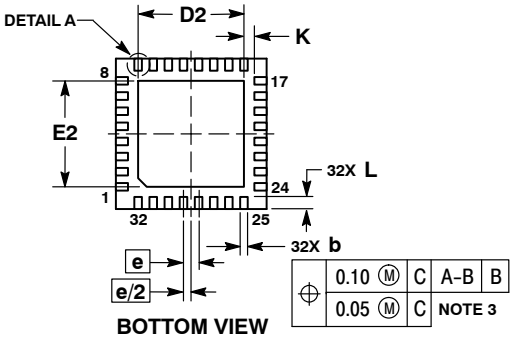


DETAIL A
ALTERNATE CONSTRUCTIONS



DETAIL B
ALTERNATE CONSTRUCTION

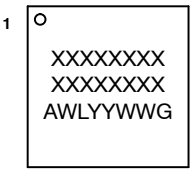




NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM THE TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS	
DIM	MIN	MAX
A	0.80	1.00
A1	---	0.05
A3	0.20 REF	
b	0.20	0.30
D	5.00 BSC	
D2	3.40	3.60
E	5.00 BSC	
E2	3.40	3.60
e	0.50 BSC	
K	0.20	---
L	0.30	0.50
L1	---	0.15

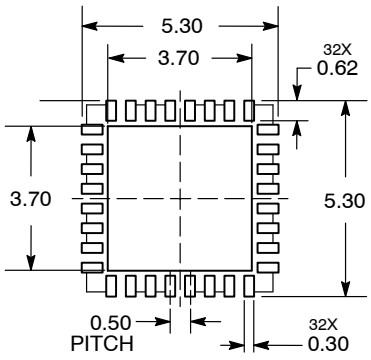
GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot
YY = Year
WW = Work Week
G = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb−Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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